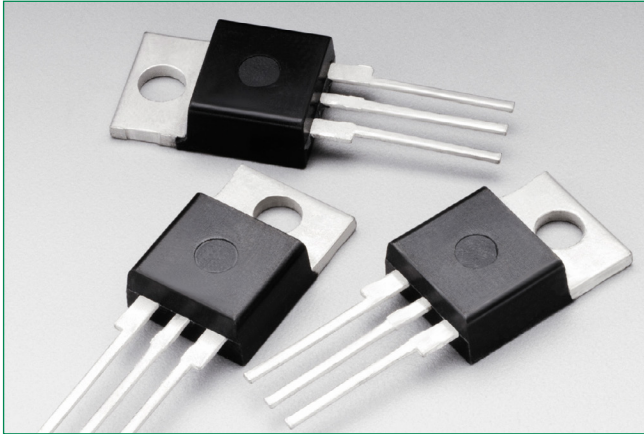


# MCR25DG, MCR25MG, MCR25NG

## Silicon Controlled Rectifiers



### Description

Designed primarily for half-wave ac control applications, such as motor controls, heating controls, and power supplies; or wherever half-wave, silicon gate-controlled devices are needed.

### Features

- Blocking Voltage to 800 Volts
- On-State Current Rating of 25 Amperes RMS
- High Surge Current Capability – 300 Amperes
- Rugged Economical TO-220AB Package
- Glass Passivated Junctions for Reliability and Uniformity
- Minimum and Maximum Values of IGT, VGT, and IH Specified for Ease of Design
- High Immunity to  $dv/dt$  – 100 V/ $\mu$ sec Minimum at 125°C
- These are Pb-Free Devices

### Additional Information



Resources



Accessories

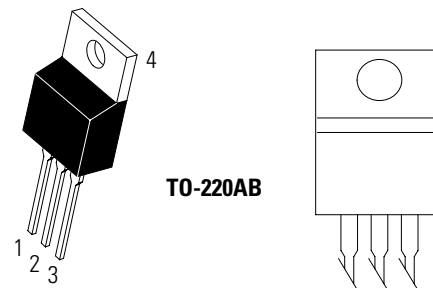


Samples

### Functional Diagram



### Pin Out



# MCR25DG, MCR25MG, MCR25NG

## Silicon Controlled Rectifiers

### Maximum Ratings (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage (Note 1) (- 40 to 125°C, Sine Wave, 50 to 60 Hz, Gate Open)	MCR25DG MCR25MG MCR25NG	V <sub>DRM'</sub> V <sub>RRM</sub>	V
On-State RMS Current (180° Conduction Angles; T <sub>c</sub> = 80°C)	I <sub>T (RMS)</sub>	25	A
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T <sub>J</sub> = 125°C)	I <sub>TSM</sub>	300	A
Circuit Fusing Consideration (t = 8.3 ms)	I <sup>2</sup> t	373	A <sup>2</sup> sec
Forward Peak Gate Power (Pulse Width ≤ 1.0 μsec, T <sub>c</sub> = 80°C)	P <sub>GM</sub>	20.0	W
Forward Average Gate Power (t = 8.3 msec, T <sub>c</sub> = 80°C)	P <sub>GM (AV)</sub>	0.5	W
Forward Peak Gate Current (Pulse Width ≤ 1.0 μsec, T <sub>c</sub> = 80°C)	I <sub>GM</sub>	2.0	A
Operating Junction Temperature Range	T <sub>J</sub>	-40 to 125	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. V<sub>DRM'</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

### Thermal Characteristics

Rating	Symbol	Value	Unit
Thermal Resistance Junction-to-Case (AC) Junction-to-Ambient	R <sub>θJC</sub> R <sub>θJA</sub>	1.5 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T <sub>L</sub>	260	°C

### Electrical Characteristics - OFF (T<sub>J</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Peak Repetitive Forward or Reverse Blocking Current (V <sub>AK</sub> = Rated V <sub>DRM'</sub> or V <sub>RRM'</sub> , Gate Open)	I <sub>DRM'</sub> I <sub>RRM</sub>	-	-	0.01	mA
		-	-	2.0	

### Electrical Characteristics - ON (T<sub>J</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Peak Forward On-State Voltage (Note 2) (I <sub>TM</sub> = 50 A)	V <sub>TM</sub>	-	-	1.8	V
Gate Trigger Current (Continuous dc) (V <sub>D</sub> = 12 V; R <sub>L</sub> = 100 Ω)	I <sub>GT</sub>	4.0	12	30	mA
Holding Current (Anode Voltage = 12 V, Initiating Current = 200 mA)	I <sub>H</sub>	5.0	13	40	mA
Latch Current (V <sub>D</sub> = 12 V, I <sub>G</sub> = 30 mA)	I <sub>L</sub>	-	35	80	mA
Gate Trigger Voltage (Continuous dc) (V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 Ω)	V <sub>GT</sub>	0.5	0.67	1.0	V

### Dynamic Characteristics

Characteristic	Symbol	Min	Typ	Max	Unit
Critical Rate of Rise of Off-State Voltage (V <sub>D</sub> = 67% of Rated V <sub>DRM'</sub> , Exponential Waveform, Gate Open, T <sub>J</sub> = 125°C)	dv/dt	100	250	-	V/μs
Critical Rate of Rise of On-State Current (I <sub>PK</sub> = 50 A, Pw = 30 μsec, di/dt = 1 A/μsec, I <sub>gt</sub> = 50 mA)	di/dt	-	-	50	A/μs

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance under different conditions.

may not be indicated by the Electrical Characteristics if operated

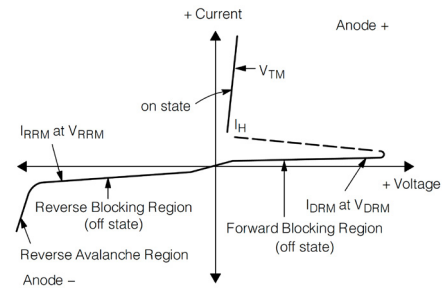
2. Pulse Test; Pulse Width ≤ 2.0 msec, Duty Cycle ≤ 2%.

# MCR25DG, MCR25MG, MCR25NG

## Silicon Controlled Rectifiers

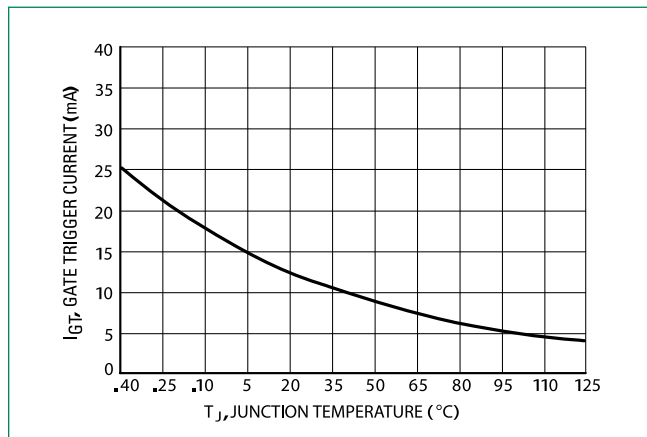
### Voltage Current Characteristic of SCR

Symbol	Parameter
$V_{DRM}$	Peak Repetitive Forward Off State Voltage
$I_{DRM}$	Peak Forward Blocking Current
$V_{RRM}$	Peak Repetitive Reverse Off State Voltage
$I_{RRM}$	Peak Reverse Blocking Current
$V_{TM}$	Maximum On State Voltage
$I_H$	Holding Current



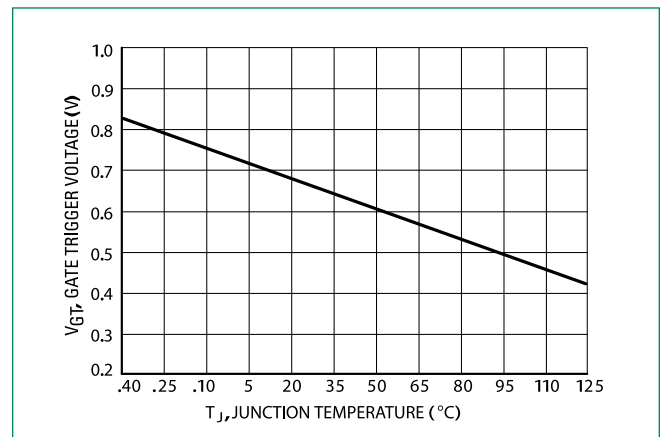
**Figure 1.**

Typical Gate Trigger Current vs Junction Temperature



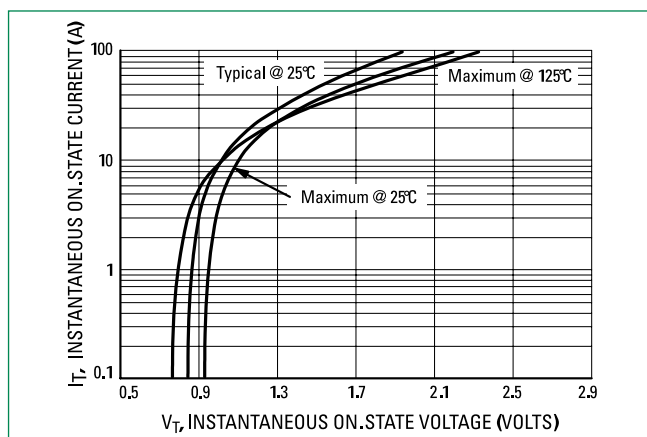
**Figure 2.**

Typical Gate Trigger Voltage vs Junction Temperature



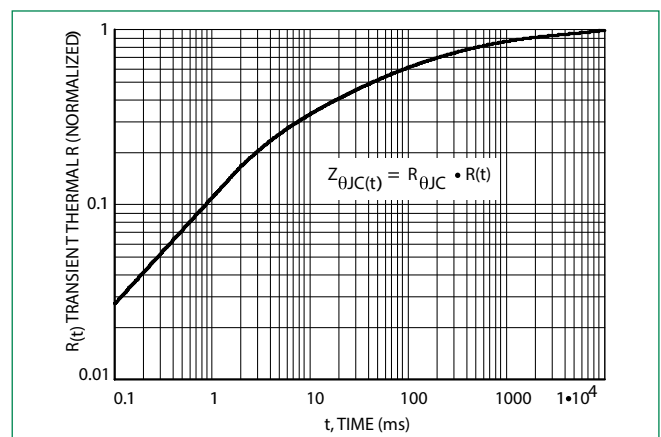
**Figure 3.**

Typical On-State Characteristics



**Figure 4.**

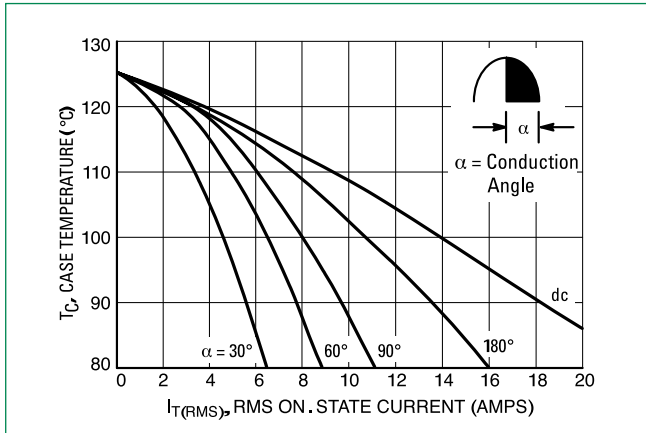
Transient Thermal Response



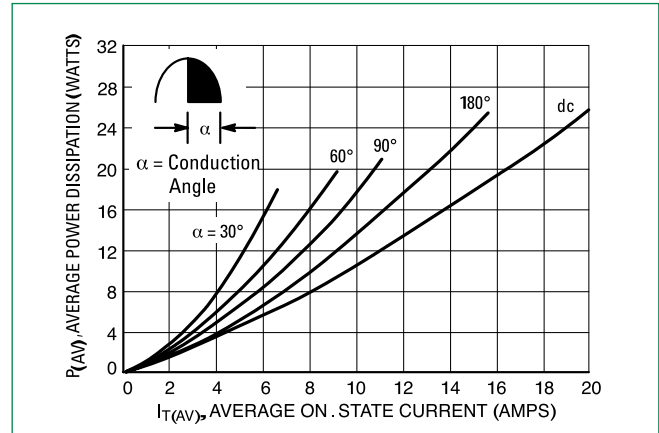
# MCR25DG, MCR25MG, MCR25NG

## Silicon Controlled Rectifiers

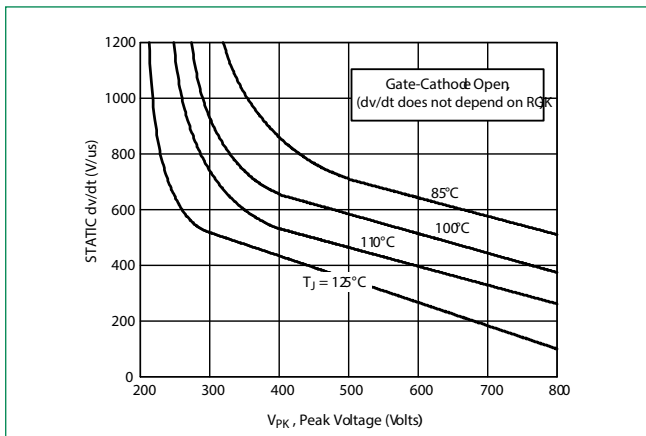
**Figure 7.**  
Typical RMS Current Derating



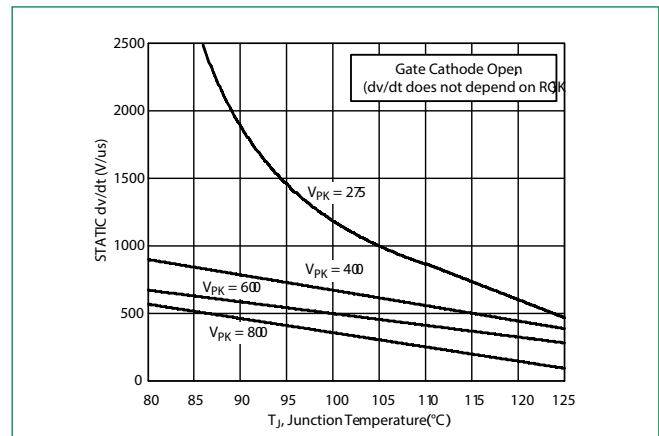
**Figure 8.**  
On State Power Dissipation



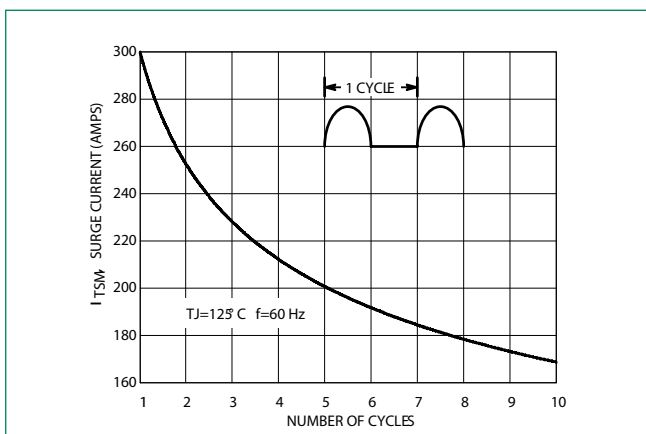
**Figure 9.**  
Typical Exponential Static dv/dt Versus Peak Voltage



**Figure 10.**  
Typical Exponential Static dv/dt Vs Junction Temperature



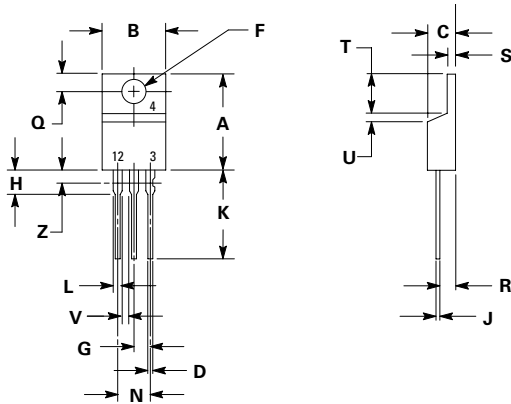
**Figure 11.**  
Maximum Non-Repetitive Surge Current



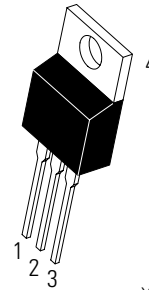
# MCR25DG, MCR25MG, MCR25NG

## Silicon Controlled Rectifiers

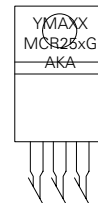
### Dimensions



### Part Marking System



**TO-220AB  
Case 221A  
Style 3**



Y =Year  
M =Month  
A =Assembly Site  
AKA =Diode Polarity  
G =Pb-Free Package

Dim	Inches		Millimeters	
	Min	Max	Min	Max
A	0.590	0.620	14.99	15.75
B	0.380	0.420	9.65	10.67
C	0.178	0.188	4.52	4.78
D	0.025	0.035	0.64	0.89
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.41	2.67
H	0.110	0.130	2.79	3.30
J	0.018	0.024	0.46	0.61
K	0.540	0.575	13.72	14.61
L	0.060	0.075	1.52	1.91
N	0.195	0.205	4.95	5.21
Q	0.105	0.115	2.67	2.92
R	0.085	0.095	2.16	2.41
S	0.045	0.060	1.14	1.52
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045	---	1.15	---
Z	---	0.080	---	2.04

Pin Assignment	
1	Cathode
2	Anode
3	Gate
4	Anode

### Ordering Information

Device	Package	Shipping
MCR25DG	TO-220AB (Pb-Free)	1000 Units / Box
MCR25MG		
MCR25NG		

1. Dimensioning and tolerancing per ansi y14.5m, 1982.  
2. Controlling dimension: inch.  
3. Dimension z defines a zone where all body and lead irregularities are allowed.

## X-ON Electronics

Largest Supplier of Electrical and Electronic Components

*Click to view similar products for [SCRs category](#):*

*Click to view products by [ON Semiconductor manufacturer](#):*

Other Similar products are found below :

[NTE5428](#) [T1500N16TOF VT](#) [TT162N16KOF-A](#) [TT162N16KOF-K](#) [TT330N16AOF](#) [VS-22RIA20](#) [VS-2N685](#) [057219R](#) [T1190N16TOF VT](#)  
[T1220N22TOF VT](#) [T201N70TOH](#) [T700N22TOF](#) [T830N18TOF](#) [TT250N12KOF-K](#) [VS-16RIA120](#) [VS-110RKI40](#) [NTE5427](#) [NTE5442](#)  
[TT251N16KOF-K](#) [VS-22RIA100](#) [VS-16RIA40](#) [TD250N16KOF-A](#) [VS-ST110S16P0](#) [T930N36TOF VT](#) [T2160N24TOF VT](#) [T1190N18TOF](#)  
[VT](#) [T1590N28TOF VT](#) [2N1776A](#) [T590N14TOF](#) [NTE5375](#) [NTE5460](#) [NTE5481](#) [NTE5512](#) [NTE5514](#) [NTE5518](#) [NTE5519](#) [NTE5529](#)  
[NTE5553](#) [NTE5555](#) [NTE5557](#) [NTE5567](#) [NTE5570](#) [NTE5572](#) [NTE5574](#) [NTE5576](#) [NTE5578](#) [NTE5579](#) [NTE5589](#) [NTE5592](#) [NTE5598](#)